



VOL. 252 NO. 3 (2006)  
International Journal of  
**Mass Spectrometry**

**Editors**

**S.A. McLuckey**  
*West Lafayette, IN*

**H. Schwarz**  
*Berlin*

*Special Issue*  
*Consultant*

**M.T. Bowers**  
*Santa Barbara, CA*

**Editorial Board**

P.B. Armentrout  
*Salt Lake City, UT*  
T. Baer  
*Chapel Hill, NC*

J.S. Becker  
*Jülich*  
V.M. Bierbaum  
*Boulder, CO*

D.K. Böhme  
*North York, Ont.*

B. Chait  
*New York, NY*  
R.G. Cooks  
*West Lafayette, IN*

M.L. Gross  
*St. Louis, MO*  
J. Grotemeyer  
*Kiel*

A.J.R. Heck  
*Utrecht*  
R.M.A. Heeren  
*Amsterdam*

G. von Helden  
*Berlin*  
F. Hillenkamp  
*Münster*

K.R. Jennings  
*Coventry*  
C.B. Lebrilla  
*Davis, CA*

S. Liu  
*Changchun*  
R.E. March  
*Peterborough, Ont.*

T.D. Märk  
*Innsbruck*  
A.G. Marshall  
*Tallahassee, FL*

T.B. McMahon  
*Waterloo, Ont.*  
N.M.M. Nibbering  
*Amsterdam*  
R.A.J. O'Hair  
*Victoria*

G. Ohanessian  
*Palaiseau*

J.M. Riveros  
*São Paulo*  
C. Robinson  
*Cambridge*  
M.T. Rodgers  
*Detroit, MI*  
C.A. Schalley  
*Bonn*

J. Scrivens  
*Middlesborough*  
R. Smith  
*Richland, WA*  
M. Speranza  
*Rome*

F. Tureček  
*Seattle, WA*  
E. Uggerud  
*Blindern*

E.R. Williams  
*Berkeley, CA*  
H. Wollnik  
*Giessen*

V.H. Wysocki  
*Tucson, AZ*  
R.A. Yost  
*Gainesville, FL*  
R. Zenobi  
*Zurich*



ELSEVIER

Amsterdam • Boston • Jena •  
London • New York • Oxford •  
Paris • Philadelphia •  
San Diego • St. Louis